

MOSFET – N-Channel, Shielded Gate, POWERTRENCH[®] 150 V, 62 A, 12.4 mΩ

FDMS86255

Description

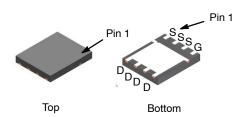
This N-Channel MOSFET is produced using **onsemi** advanced POWERTRENCH process that incorporates Shielded Gate technology. This process has been optimized for the on-state resistance and yet maintain superior switching performance.

Features

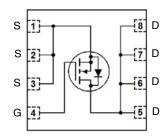
- Shielded Gate MOSFET Technology
- Max $R_{DS(on)} = 12.4 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 10 \text{ A}$
- Max $R_{DS(on)} = 15.5 \text{ m}\Omega$ at $V_{GS} = 6 \text{ V}$, $I_D = 8 \text{ A}$
- Advanced Package and Silicon Combination for Low R_{DS(on)} and High Efficiency
- Next Generation Enhanced Body Diode Technology, Engineered for Soft Recovery
- MSL1 Robust Package Design
- 100% UIL Tested
- RoHS Compliant
- These Device is Halogen Free

Applications

- OringFET / Load Switching
- Synchronous Rectification
- DC-DC Conversion



PQFN8 5X6, 1.27P CASE 483AG



MARKING DIAGRAM



\$Y = Logo

&Z = Assembly Location

&3 = Date Code (Year and Week)

&K = Specific Device Code

ORDERING INFORMATION

See detailed ordering and shipping information on page 6 of this data sheet.

MOSFET MAXIMUM RATINGS $T_A = 25$ °C unless otherwise noted

Symbol	Parameter	Rating	Unit
V _{DS}	Drain to Source Voltage	150	V
V_{GS}	Gate to Source Voltage	±20	V
I _D	Drain Current Continuous, T _C = 25°C	62	Α
	Continuous, T _A = 25°C (Note 1a)	10	
	Pulsed (Note 4)	271	
E _{AS}	Single Pulse Avalanche Energy (Note 3)		mJ
P_{D}	Power Dissipation, T _C = 25°C		W
	Power Dissipation, T _A = 25°C (Note 1a)	2.7	
$T_{J_i} T_{STG}$	Operating and Storage Junction Temperature Range		°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

Symbol	Parameter	Rating	Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case	1.1	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	45	

ELECTRICAL CHARACTERISTICS $T_A = 25^{\circ}C$ unless otherwise noted

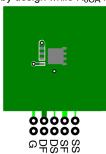
Symbol	Parameter	Test Con	ditions	Min.	Тур.	Max.	Unit
OFF CHARACTERISTICS							
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu\text{A}, V_{GS} = 0 \text{V}$		150	-	-	V
ΔBV _{DSS} ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, reference	d to 25°C	-	109	-	mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 120 \text{ V}, V_{GS} = 0$	V	-	_	1	μΑ
I_{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0$	V	-	-	±100	nA
ON CHARA	CTERISTICS						_
VGS(th)	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250 \mu$	A	2.0	3.0	4.0	V
$\Delta VGS(th)$ ΔT_J	Gate to Source Threshold Voltage Temperature Coefficient	I _D = 250 μA, reference	d to 25°C	_	-11	-	mV/°C
R _{DS(ON)}	Static Drain to Source On Resistance	$V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$	$V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$ $V_{GS} = 6 \text{ V}, I_D = 8 \text{ A}$ $V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}, T_J = 125^{\circ}\text{C}$		9.5	12.4	mΩ
		V _{GS} = 6 V, I _D = 8 A			11.5	15.5	
		$V_{GS} = 10 \text{ V}, I_D = 10 \text{ A},$			19	25	
9FS	Forward Transconductance	V _{DS} = 5 V, I _D = 10 A		-	35	_	S
DYNAMIC C	CHARACTERISTICS						
C _{ISS}	Input Capacitance		$V_{DS} = 75 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1 MHz		3200	4480	pF
C _{OOS}	Output Capacitance	f = 1 MHz			291	410	pF
Crss	Reverse Transfer Capacitance			-	11	20	pF
R_{g}	Gate Resistance				0.7	2.1	Ω
SWITCHING CHARACTERISTICS							
t _{d(on)}	Turn-On Delay Time	V_{DD} = 75 V, I_{D} = 10 A, V_{GS} = 10 V, R_{GEN} = 6 Ω		-	21	34	ns
t _r	Rise Time			-	4.5	10	ns
t _{d(off)}	Turn-Off Delay Time			-	28	45	ns
t _f	Fall Time			-	6.2	12	ns
Qg	Total Gate Charge	V _{GS} = 0 V to 10 V	V _{DD} = 75 V,	-	45	63	nC
Qg	Total Gate Charge	V _{GS} = 0 V to 6 V		-	29	41	nC

ELECTRICAL CHARACTERISTICS (continued) $T_A = 25$ °C unless otherwise noted

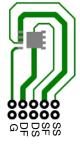
\ / A								
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit		
SWITCHING	SWITCHING CHARACTERISTICS							
Qgs	Gate to Source Charge		-	14	_	nC		
Qgd	Gate to Drain "Miller" Charge		-	8.8	_	nC		
DRAIN-SOURCE DIODE CHARACTERISTICS								
V_{SD}	Source to Drain Diode Forward	V _{GS} = 0 V, I _S = 1.9 A (Note 2)	-	0.7	1.2	V		
	Voltage	V _{GS} = 0 V, I _S = 10 A (Note 2)	-	0.8	1.3			
t _{rr}	Reverse Recovery Time	I _F = 10 A, di/dt = 100 A/μs	-	87	139	ns		
Q _{rr}	Reverse Recovery Charge]	_	165	264	nC		

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

1. $R_{\theta JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a. 45°C/W when mounted on a 1 in² pad of 2 oz copper.



b. 115°C/W when mounted on a minimum pad of 2 oz copper.

- Pulse Test: Pulse Width < 300 µs, Duty cycle < 2.0%.
 E_{AS} of 541 mJ is based on starting T_J = 25 °C, L = 3 mH, I_{AS} = 19 A, V_{DD} = 150 V, V_{GS} = 10 V. 100% tested at L = 0.1 mH, I_{AS} = 60 A.
 Pulse Id refers to Figure.11 Forward Bias Safe Operation Area.

TYPICAL CHARACTERISTICS T_{.J} = 25°C unless otherwise noted

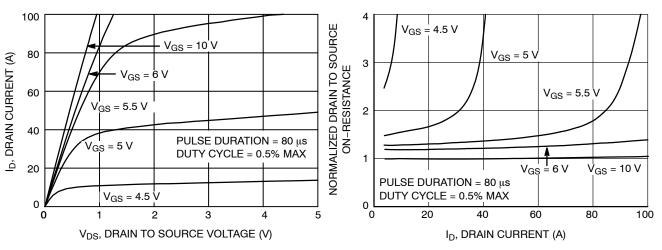


Figure 1. On-Region Characteristics

Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

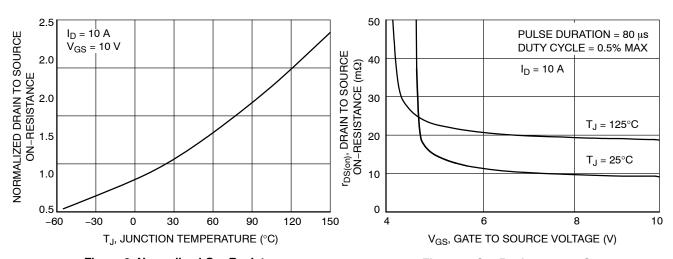


Figure 3. Normalized On-Resistance vs Junction Temperature

Figure 4. On-Resistance vs Gate to Source Voltage

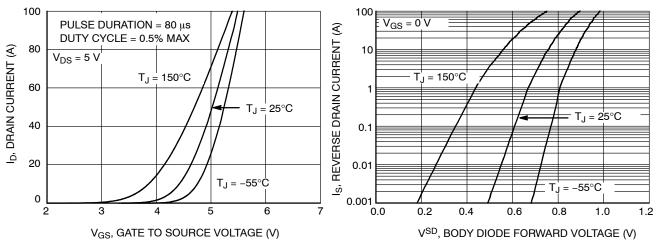


Figure 5. Transfer Characteristics

Figure 6. Source to Drain Diode Forward Voltage vs Source Current

TYPICAL CHARACTERISTICS (continued) T_J = 25°C unless otherwise noted

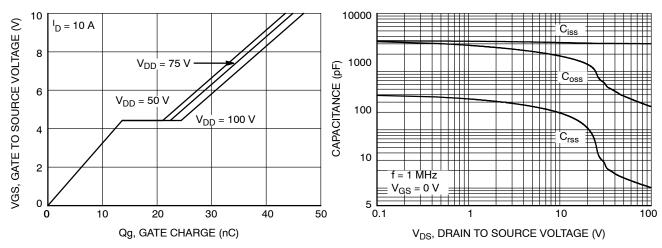


Figure 7. Gate Charge Characteristics

Figure 8. Capacitance vs Drain to Source Voltage

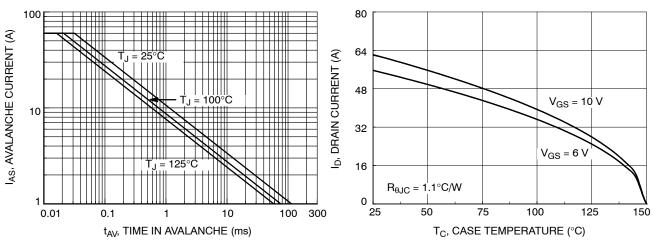


Figure 9. Unclamped Inductive Switching Capability

Figure 10. Maximum Continuous Drain Current vs Case Temperature

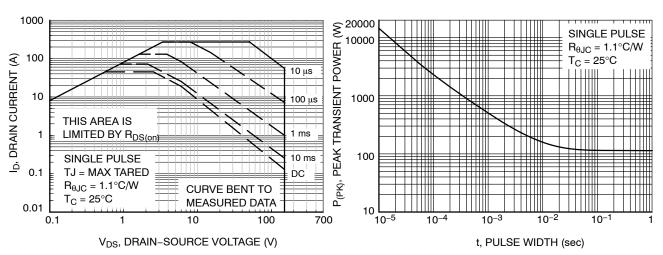


Figure 11. Forward Bias Safe Operating Area

Figure 12. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS (continued) $T_J = 25^{\circ}C$ unless otherwise noted

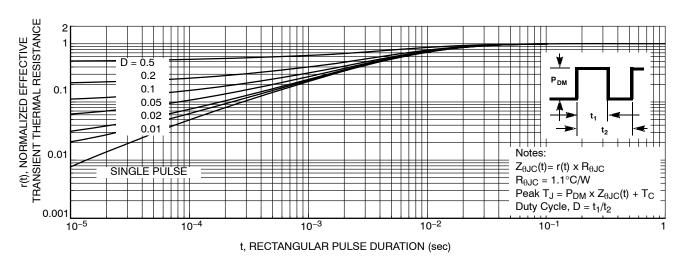


Figure 13. Transient Thermal Response Curve

ORDERING INFORMATION

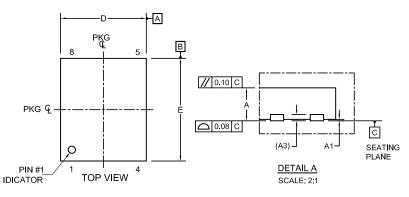
Device Marking	Device	Package	Reel Size	Tape Width	Shipping [†]
FDMS86255	FDMS86255	PQFN8 (Halogen Free)	13"	12 mm	3000 / Tape and Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.



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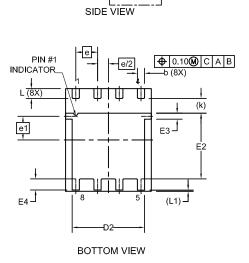
DATE 25 JUN 2021

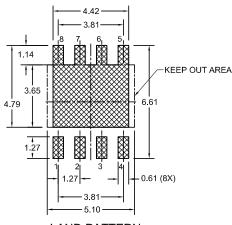


SEE DETAIL A

NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
- 4. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
- 5. SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.
- 6. IT IS RECOMMENDED TO HAVE NO TRACES OR VIAS WITHIN THE KEEP OUT AREA.





LAND PATTERN RECOMMENDATION

*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

511.4	MILLIMETERS				
DIM	MIN.	NOM.	MAX.		
Α	0.90	1.00	1.10		
A1	0.00	-	0.05		
A3	().20 REF			
b	0.37	0.42	0.47		
D	4.90	5.00	5.10		
D2	4.13	4.23	4.33		
Е	5.90	6.00	6.10		
E2	3.74	3.84	3.94		
E3	0.25	0.35	0.45		
E4	0.60	0.70	0.80		
е	1,27 BSC				
e/2	0.635 BSC				
e1	1.31 BSC				
k	0.86 REF				
L	0.47	0.57	0.67		
L1	0.08REF				

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